Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/617,113	CHOWN, DAVID	
Examiner	Art Unit	
Leslie Pascal	2613	

bclass	Date	Examiner
		Examiner
5-139	11/7/2006	LP
22	6/26/2007	LP

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			:		
SEE SEAR	CH NOTES	2/24/2007	LP		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
see search notes		11/6/2007	LP		
see search notes		6/26/2007	LP		
see search notes		11/25/2007	LP		
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